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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/044,141	01/11/2002	Jong Sik Pack	AMKOR-018A	1112
7663	7590	10/23/2003	EXAMINER	
STETINA BRUNDA GARRED & BRUCKER 75 ENTERPRISE, SUITE 250 ALISO VIEJO, CA 92656			CHU, CHRIS C	
			ART UNIT	PAPER NUMBER
			2815	

DATE MAILED: 10/23/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Applicati n N .

10/044,141

Applicant(s)

PAEK, JONG SIK

Examiner

Chris C. Chu

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 11 August 2003.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1 - 21 and 27 - 31 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1 - 21 and 27 - 31 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on _____ is: a) ☐ approved b) ☐ disapproved by the Examiner.
- If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892) 4) ☐ Interview Summary (PTO-413) Paper No(s). _____
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948) 5) ☐ Notice of Informal Patent Application (PTO-152)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449) Paper No(s) 3 and 4 . 6) ☐ Other: _____

DETAILED ACTION

Claim Rejections - 35 USC § 102

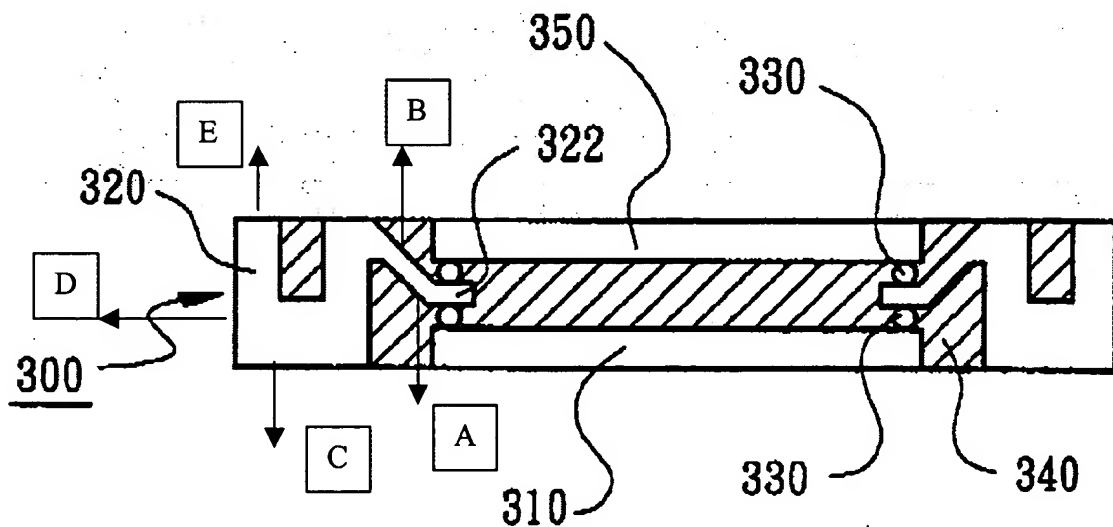
1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

2. Claims 1 ~ 6 and 11 ~ 21 are rejected under 35 U.S.C. 102(e) as being anticipated by Chun-Jen et al.

Regarding claim 1, Chun-Jen et al. discloses in Fig. 5 a semiconductor package comprising:



- a plurality of leads (320), each of the leads defining:

- a first surface (A);
 - a second surface (B) disposed in opposed relation to the first surface; and
 - a third surface (C) disposed in opposed relation to the second surface and laterally offset outwardly relative to the first surfaces;
- a first semiconductor die (310) defining opposed top and bottom surface;
 - a second semiconductor die (350) defining opposed top and bottom surfaces;
 - a plurality of conductive connectors (330) electrically and mechanically connecting the first semiconductor die to the first surfaces of the leads and the second semiconductor die to the second surfaces of the leads; and
 - an encapsulating portion (340) applied to and at least partially encapsulating the leads, the first and second semiconductor dies, and the conductive connectors.

Regarding claim 2, Chun-Jen et al. discloses in Fig. 5 and column 3, line 62 the conductive connectors each comprising a conductive bump (330).

Regarding claim 3, Chun-Jen et al. discloses in Fig. 5 and column 2, line 38 the conductive bump being fabricated from material selected from solder.

Regarding claim 4, Chun-Jen et al. discloses in Fig. 5

- the first semiconductor die (310) includes a plurality of bond pads (under 330, at the top) disposed on the top surface thereof;
- the second semiconductor die (350) includes a plurality of bond pads (under 330, at the bottom) disposed on the bottom surface thereof; and
- the conductive connectors (330) are used to electrically and mechanically connect the bond pads of the first semiconductor die to respective ones of the first surfaces of the

leads and the bond pads of the second semiconductor die to respective ones of the second surfaces of the leads.

Regarding claim 5, Chun-Jen et al. discloses in Fig. 5 the conductive connectors each comprising a conductive bump.

Regarding claim 6, Chun-Jen et al. discloses in Fig. 5

- each of the leads (320) includes a first bump land formed at a prescribed region of the first surface thereof and a second bump land formed at a prescribed region of the second surface thereof;
- the conductive connectors (330) each comprise a conductive bump; and
- the conductive bumps are fused to respective ones of the first and second bump lands of each of the leads.

Regarding claim 11, Chun-Jen et al. discloses in Fig. 5 the first and second semiconductor dies being identically sized.

Regarding claim 12, Chun-Jen et al. discloses in Fig. 5 the encapsulating portion being applied to the leads such that the third surface of each of the leads is exposed within the encapsulating portion.

Regarding claim 13, Chun-Jen et al. discloses in Fig. 5 the encapsulating portion (340) being applied to the first and second semiconductor dies such that the bottom surface of the first semiconductor die and the top surface of the second semiconductor die are each exposed within the encapsulating portion.

Regarding claim 14, Chun-Jen et al. discloses in Fig. 5 the leads and the first semiconductor die being oriented relative to each other such that the bottom surface of the first semiconductor die is substantially flush with the third surface of each of the leads.

Regarding claim 15, Chun-Jen et al. discloses in Fig. 5

- each of the leads (320) further defines an outer end (D) which extends between the second and third surfaces thereof; and
- the encapsulating portion is applied to the leads such that the outer end of each of the leads is exposed within the encapsulating portion.

Regarding claim 16, Chun-Jen et al. discloses in Fig. 5 each of the leads (320) further defines a fourth surface (E) disposed in opposed relation to the third surface and laterally offset outwardly relative to the second surface.

Regarding claim 17, Chun-Jen et al. discloses in Fig. 5 the encapsulating portion being applied to the leads such that the third and fourth surfaces of each of the leads are exposed within the encapsulating portion.

Regarding claim 18, Chun-Jen et al. discloses in Fig. 5 the encapsulating portion being applied to the first and second semiconductor dies such that the bottom surface of the first semiconductor die and the top surface of the second semiconductor die are each exposed within the encapsulating portion.

Regarding claim 19, Chun-Jen et al. discloses in Fig. 5 the second semiconductor die and the leads being oriented relative to each other such that the top surface of the second semiconductor die is substantially flush with the fourth surface of each of the leads.

Regarding claim 20, Chun-Jen et al. discloses in Fig. 5 the first semiconductor die and the leads being oriented relative to each other such that the bottom surface of the first semiconductor die is substantially flush with the third surface of each of the leads.

Regarding claim 21, Chun-Jen et al. discloses in Fig. 3, Fig. 5 and column 3, line 56 ~ column 4, line 2 further in combination with a second semiconductor package identically configured to the semiconductor package, the third surfaces of the leads of the second semiconductor package being electrically connected to respective ones of the fourth surfaces of the leads of the semiconductor package.

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

4. Claims 7 ~ 10 and 27 ~ 31 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chun-Jen et al. in view of Kim.

Regarding claim 7, Chun-Jen et al. discloses the claimed invention except for each of the leads including first and second protective layers on the bump land. However, Kim teaches in Fig. 2, Fig. 3 and column 3, lines 34 ~ 54 each of the leads (3) including a first protective layer (7, at the left) coated on the first surface thereof about a respective one of the conductive

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connectors; and a second protective layer (7, at the right) coated on the second surface thereof about a respective one of the conductive connectors. Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to modify Chun-Jen et al. by using first and second protective layers as taught by Kim. The one of ordinary skill in the art would have been motivated to modify Chun-Jen et al. in the manner described above for at least the purpose of covering the bonding pads by a protective film in a simple and effective way (column 2, lines 25 ~ 28).

Regarding claim 8, Kim discloses in column 3, line 44 the protective layer being selected from the group consisting of aluminum.

Regarding claim 9, Chun-Jen et al. discloses the claimed invention except for each of the leads including first and second protective layers on the bump land. However, Kim teaches in Fig. 2, Fig. 3 and column 3, lines 34 ~ 54 each of the leads (3) including a first protective layer (7, at the left) coated on the first surface thereof about a respective one of the conductive connectors; and a second protective layer (7, at the right) coated on the second surface thereof about a respective one of the conductive connectors. Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to modify Chun-Jen et al. by using first and second protective layers as taught by Kim. The one of ordinary skill in the art would have been motivated to modify Chun-Jen et al. in the manner described above for at least the purpose of covering the bonding pads by a protective film in a simple and effective way (column 2, lines 25 ~ 28).

Regarding claim 10, Kim discloses in column 3, line 44 the protective layer being selected from the group consisting of aluminum.

Regarding claim 27, Chun-Jen et al. discloses in Fig. 5 a semiconductor package comprising:

- a plurality of leads (320);
- first (310) and second (350) semiconductor dies electrically and mechanically connected to the leads in opposed relation to each other through the use of a plurality of conductive connectors (330); and
- an encapsulating portion (340) applied to and at least partially encapsulating the leads, the first and second semiconductor dies, and the conductive connectors such that portions of the leads are exposed in a common exterior surface of the encapsulating portion.

Chun-Jen et al. discloses the claimed invention except for means disposed on each of the leads for maintaining the conductive connectors in prescribed locations thereon. However, Kim teaches in Fig. 2, Fig. 3 and column 3, lines 34 ~ 54 means disposed on (7) each of the leads for maintaining the conductive connectors in prescribed locations thereon. Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to modify Chun-Jen et al. by using the means as taught by Kim. The one of ordinary skill in the art would have been motivated to modify Chun-Jen et al. in the manner described above for at least the purpose of covering the bonding pads by a protective film in a simple and effective way (column 2, lines 25 ~ 28).

Regarding claim 28, Chun-Jen et al. discloses in Fig. 5 a portion of one of the first and second semiconductor dies being exposed in the exterior surface of the encapsulating portion.

Regarding claim 29, Chun-Jen et al. discloses in Fig. 5 the encapsulating portion defining an opposed pair of exterior surfaces, and portions of the first and second semiconductor dies being exposed in respective ones of the exterior surfaces.

Regarding claim 30, Chun-Jen et al. discloses in Fig. 5 a semiconductor package comprising:

- a plurality of leads (320);
- first (310) and second (350) semiconductor dies electrically and mechanically connected to the leads in opposed relation to each other through the use of a plurality of conductive connectors (330); and
- an encapsulating portion (340) applied to and at least partially encapsulating the leads, the first and second semiconductor dies, and the conductive connectors such that portions of each of the leads are exposed in respective ones of an opposed pair of exterior surfaces of the encapsulating portion.

Chun-Jen et al. discloses the claimed invention except for means disposed on each of the leads for maintaining the conductive connectors in prescribed locations thereon. However, Kim teaches in Fig. 2, Fig. 3 and column 3, lines 34 ~ 54 means disposed on (7) each of the leads for maintaining the conductive connectors in prescribed locations thereon. Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to modify Chun-Jen et al. by using the means as taught by Kim. The one of ordinary skill in the art would have been motivated to modify Chun-Jen et al. in the manner described above for at least the purpose of covering the bonding pads by a protective film in a simple and effective way (column 2, lines 25 ~ 28).

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Regarding claim 31, Chun-Jen et al. discloses in Fig. 3, Fig. 5 and column 3, line 56 ~ column 4, line 2 further in combination with a second semiconductor package identically configured to the semiconductor package, at least some of the leads of the second semiconductor package being electrically connected to at least some of the leads of the semiconductor package.

Conclusion

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Venkateshwaran et al., Mori, Hsuan et al., Pu, Honda et al., Yamazaki, Otsuka et al. and Iwamatsu disclose a semiconductor device.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chris C. Chu whose telephone number is (703) 305-6194. The examiner can normally be reached on M-F (10:30 - 7:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (703) 308-2772. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

**GEORGE ECKERT
PRIMARY EXAMINER**

Chris C. Chu
Examiner
Art Unit 2815

c.c.
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